

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/726,253	PATTON ET AL.	
Examiner	Art Unit	
Yuzhen Ge	2624	

SEARCHED						
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout	5/14/2007	YG		
Search 382/167 with text limitations	5/14/2007	YG		